Chip tantalum capacitors

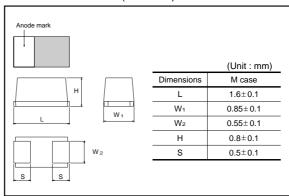
TC Series

●Features (M)

Newly designed ROHM original CSP structure (face-down terminal) provides,

- 1) Excellent adhesion.
- 2) Easy visual recognition of fillets.
- 3) Expanded capacitance range with Low ESR.

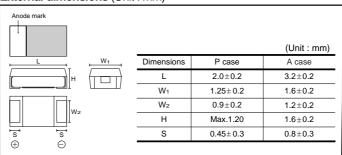
●External dimensions (Unit : mm)



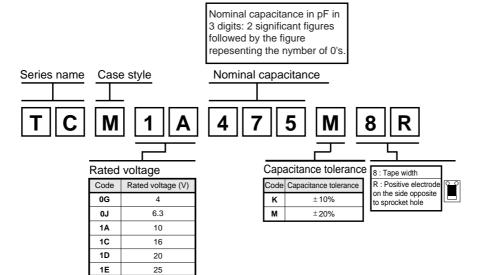
●Features (P,A)

- 1) Vital for all hybrid integrated circuits board application.
- 2) Wide capacitance range.
- 3) Screening by thermal shock.

●External dimensions (Unit : mm)

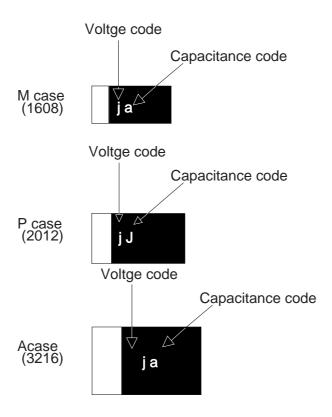


●Model name configuration



●Rated Table. Marking

μF		4 0G	6.3 0J	10 1A	16 1C	20 1D	25 1E
Α	1.0			M,P	M,P,A	P,A	P,A
Е	1.5		Р	P,A	Α	Α	Α
J	2.2	Р	Р	M,P,A	Α	Α	Α
N	3.3	Р	P,A	P,A	Α	Α	Α
S	4.7	M,P,A	M,P,A	M,P,A	Α	Α	
W	6.8	P,A	W,P,A	P,A	Α		
а	10	M,P,A	M,P,A	P,A	Α		
е	15	P,A	P,A	Α			
j	22	M,P,A	Α	Α			
n	33	Α	Α				
S	47	Α	Α				
W	68	Α					



● Characteristics

Item						Pe	rforr	(b	(based c		st conditions 5101–1 and JIS C 5101–3)	
Operating Tempe	erature	–55℃~+125℃						Volta	Voltage reduction when temperature exceeds+859			
Maximum operat temperature with derating		+85℃	35℃									
Rated voltage		M case	4	4 6.3 10 16					at 85℃			
(VDC)		P, Acase	4	6.3	10	16	20		1			
Category voltage		M case	2.5	4	6.3	10		at 12	125℃			
(VDĆ)		P, Acase	2.5	4	6.3	10	13		-			
Surge voltage		M case	5.2	8	13	20		at 85	at 85℃			
(VDC)		P, Acase	5.2	8	13	20	26					
DC Leakage current		0.5 uE or 0	0.5 μF or 0.01CV whichever is greater Shown in " Standard list "						ase	Ratedvo	Itage for 5min	
									Acase	e Rated voltage for 1min		
Capacitance tole	rance	M case	±20% Shall be satisfied allowance range.						Measuring frequency : 120±12Hz Measuring voltage : 0.5Vrms			
		P,Acase	±10%, ±20% Shall be satisfied allowance range.						+1.5~2V.DC Measuring circut : DC Equivalent series circu			
Tangent of loss a (Df, $tan \delta$)	ingle	Shall be sa	all be satisfied the voltage on " Standard list "						Measuring frequency : 120±12Hz Measuring voltage : 0.5Vrms +1.5~2V.DC Measuring circut : DC Equivalent series circu			
Impedance		Shall be sa	Shall be satisfied the voltage on " Standard list "						Measuring frequency : 100±10kHz Measuring voltage : 0.5Vrms or less			
Resistance to Soldering heat	Appea- rance	There shou The indicat						Sold	lder tem	older bat p	: 260±5℃	
	L.C.	M case	Le	ss tl	han	200°	% of		ration		: 5±0.5s : 1	
		P,Acase	Sh	nall t	e sa	atisfi	ed t	No.6	Repetition : 1			
	ΔC / C	M case	W	ithin	±20	% o	f init					
		P case	±10% of initial value									
		A case	± 5% of initial value									
	Df	M case	Le	ss tl	han	200	% of					
	(tan δ)	P case	Le	ss tl	han	150°	% of					
		A case	Le	ss t	han	initia	al lin					

Item			Performance	(ba	ase		conditions 01–1 and JIS C 5101–3)		
Temperature cycle	Appea- rance	There shou	ıld be no significant abnormality.			tion: 5 cycles e: steps 1~4)	without discontinuation.		
	L.C	M case	Less than 200% of initial limit						
		P, A case	Less than initial limit	ĺг		Temp.	Time		
	ΔC / C	M cas	Within ±20% of initial limit	1	1	-55±3°C	30±3min		
		P case	1~10μF: within ±10% of initial value 15~22μF: within ±20% of initial value		2	Room temp.	3min.or less		
		A case	TCA1A226 , TCA0J476 : Within±15% of intial value Others: Within±10% of initial value		4	125±2℃ Room temp.	30±3min 3min.or less		
	Df	M case	Less than 200% of initial limit						
	(tan δ)	P case	Less than 150% of initial limit						
		A case	Less than initial limit						
Moisture resistance	Appea- rance		lld be no significant abnormality. ions should be				ble under such atmospheri perature and humidity are		
	L.C	M case	Less than 200% of initial limit				RH,respectively,for 500		
		P , A case	Shall be satisfied the value in Item No.6			at room ature for 1 to 2	h and then measure the		
	ΔC / C	M , P case	Within± 20% of initial limit		nple		in and their measure the		
		A case	Within± 10% of initial limit	-					
	Df			-					
	(tan δ)	M case	Less than 200% of initial limit	-					
	, ,	P case	Less than 150% of initial limit						
		A casr	Less than initial limit						
Temperature Stebility	Temp.		_55℃						
	ΔC / C	M , P case	Within 0/–15% of initial value						
		A case	Within 0/–12% of initial value						
	Df (tan δ)	Shall be sa	tisfied the voltage on " Standard list "						
	L.C		-						
	Temp.		+85℃						
	ΔC/C	M , P case	Within +15/0 of initial value						
		A case	Within +12/0% of initial value						
	Df (tan δ)	Shall be sa	titisfied the voltage on " Standard list "						
	L.C	5 µA or 0.1	CV whitchever is greater	-					
	Temp.	- FILL ST. ST.	+125°C	1					
	•	M P.coco	Within +20/0 of initial value						
	ΔC / C			-					
		A case	Within +15/0% of initial value	-					
	Df (tan δ)	Shall be sa	tisfied the voltage on " Standard list "						
	L.C	6.3 μA or 0	.125CV whitchever is greater						
Surge voltage	Appea- rance	There shou	ıld be no significant avnormality.	for	30±	5 s. each time	rgevoltage every 5±0.5 mi		
	L.C	M case	Less than 200% of initial limit	of 85±2°C. Repeat this rocedure 1,000 times.					
		P, A case				ans rocedule	1,000 111163.		
	ΔC/C	M case	Within± 20% of initial value	1					
		P case	Within± 10% of initial value	1					
	Df	M case	Less than 200% of initial limit	1					
	(tan δ)	P case	Less than 150% of initial limit	1					
		A case	Less than initial limit						

Item			Performance	Test conditions (based on JIS C 5101–3)		
Loading at High temperature			There should be nosignificant abnormality. There should be nosignificant abnormality. The indications should	M , P case : After applying the rated voltage for 1000^{+36} h without discontinuation via the serial resistance of 3Ω or less at a tempera-		
	L.C	M case Less than 200% of initial limit		ture of 85±2°C, leave the sample at room temperature / humidity for 1 to 2h and mea-		
		P , A case	Less than initial limit	sure the value.		
	∆C / C	M case	Within ± 20% of initial value	A case : After applying the rated voltage		
		P case	Within± 10% of initial value	for 2000 ⁺⁷² h without discontinuation via the		
		A case	TCA1A226 ☐, TCA0J476 ☐ within ±15% of initial value Others	serial resistance of 3Ω or less at a temperature of $85\pm2^{\circ}\text{C}$, leave the sample at room		
			within ±10% of initial value	temperature / humidity for 1 to 2h and mea-		
	Df (tan S)	M case	Less than 200% of initial limit	sure the value.		
	(tan δ)	P case	150% of initial limit less than			
		A case Less than initial limit				
Terminal strength	Capacitance	The measu	red value should be stable.	A force is applied to the terminal until it bends		
	Appearance	There shou	ld nosignificant abnormality.	to 1mm and by a perscribed tool maintain the condition for5s.(See the figure below)		
Adhesiveness		The termin	al should not come off.	Apply force of 5N in the two directions shown in the figure below for 10±1s after mounting the terminal on a circuit board.		
Dimensions		Refer to "F	xternal dimensions"	Apply force a circuit board		
Difficitions		Relei to E.	kternal dimensions	Measure using a caliper of JISB 7507 Class 2 or higher grade.		
Resistance to solve	ents	The indicati	ion should be clear	Dip in the isopropyl alcohol for 30±5s, at room temperature.		
Solderability		terminal dip	re surface area of the solder coated oped in the soldering bath should with the new solder.	Dip speed=25±2.5mm / s Pre-treatment(accelerated aging): Leave the sample on the boiling distilled water for 1 h. Solder temp.: 235±5°C Duration : 2±0.5s Solder : H63A Flux : Rosin25% IPA75%		
Vibration	Capacitance	Measure va measureme	alue shoule not fluctuate during the ent.	Frequency : 10 to 55 to 10Hz/min. Amplitude : 1.5mm Time : 2h each in X and Ydirections		
	Appearance	There sho	uld no significant abnormality.	Mounting: The terminal is soldered on a print circuit board.		

●Standard list, TC series

< M case : 1608 size >

Part No.	Rated Voltage 85°C	Category Voltage 125°C	Surge Voltage 85°C	Cap. 120Hz	Tolerance	Leakage Current 25°C	Df 120Hz (%)			Impedance 100kHz
	(V)	(V)	(V)	(μF)	(%)	1WV 5min (μA)	–55°C	25℃ 85℃	125℃	(Ω)
TC M 0G 475 □				4.7		0.5				
TC M 0G 106 □	4	2.5	5.2	10	±20	0.5	30	20	30	9.0
TC M 0G 226 □				22		1.8				
TC M 0J 475 □				4.7		0.5				
TC M 0J 685 □	6.3	4	8	6.8	±20	0.5	30	20	30	9.0
TC M 0J 106 □				10		0.6				
TC M 1A 105 □				1.0			15	10	15	15.0
TC M 1A 225 □	10	6.3	13	2.2	±20	0.5	20	20	30	13.5
TC M 1A 475 □				4.7			30	20		9.0
TC M 1C 105 □	16	10	20	1.0	±20	0.5	15	10	15	15.0

□=Tolerance (M :±20%)

< P case : 2012 size >

Part No.	Rated Voltage 85°C	Cstegory Voltage 125°C	Surge Voltage 85°C	Cap. 120Hz	Tolerance	Leakage Current 25°C	Г	Of 120H (%)	łz	Impedance 100kHz
	(V)	(V)	(V)	(mF)	(%)	1WV.60s (mA)	–55°℃	25℃ 85℃	125℃	(Ω)
TC P 0G 225 □				2.2			15	10	15	
TC P 0G 335 □				3.3						
TC P 0G 475 □				4.7		0.5			30	
TC P 0G 685 □	4	2.5	5.2	6.8	±20,10		30	20		27.5
TC P 0G 106□				10						
TC P 0G 156□				15		0.6				
TC P 0G 226□				22		0.9				
TC P 0J 155□				1.5			15	10	15	
TC P 0J 225□				2.2						
TC P 0J 335□				3.3		0.5				
TC P 0J 475□	6.3	4	8	4.7	±20,10		30	20	30	27.5
TC P 0J 685□				6.8						
TC P 0J 106□				10		0.6				
TC P 0J 156□				15		0.9				
TC P 1A 105 □				1.0			15	10	15	
TC P 1A 155 □				1.5						
TC P 1A 225 □				2.2						
TC P 1A 335 □	10	6.3	13	3.3	+20,10	0.5	30	20	30	27.5
TC P 1A 475 □				4.7			30	20	30	
TC P 1A 685 □				6.8	1					
TC P 1A 106 □				10						
TC P 1C 105 □	16	10	20	1.0	±20,10	0.5	15	10	15	27.5

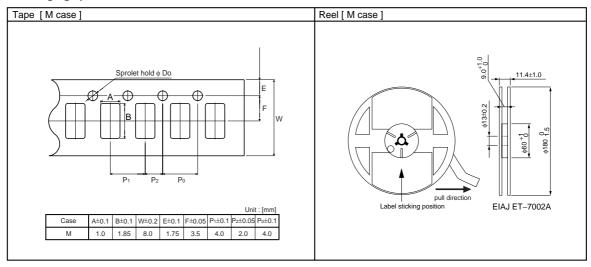
□=Tolerance (M :±20%,K:±10%)

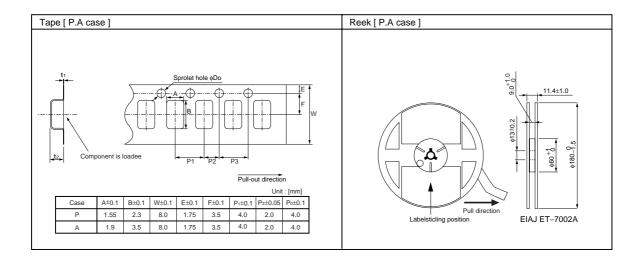
< A case : 3216 s

Part No.	Rated Voltage 85°C	Category Voltage 125°C	Surge Voltage 85℃	Cap. 120Hz	Tolerance	Leakage Current 25°C		Df 120Hz (%)		Impedance 100kHz
r div vo.	(V)	(V)	(V)	(μF)	(%)	1WV 5min (μA)	–55°℃	25℃ 85℃	125℃	(Ω)
TC A 0G 475□				4.7			10	6	8	
TC A 0G 685□				6.8		0.5				
TC A 0G 106□				10			40		10	
TC A 0G 156□		2.5	F 2	15		0.6	12	8		
TC A 0G 226□	4	2.5	5.2	22	±20,10	0.9				20.0
TC A 0G 336□				33		1.3	14	10	12	
TC A 0G 476□				47		1.9	30	12	16	
TC A 0G 686 □				68]	2.7	34	18	24	
TC A 0J 335□				3.3			10	6	8	
TC A 0J 475□				4.7]	0.5			10	20.0
TC A 0J 685□				6.8			40			
TC A 0J 106□	6.3			10	100.40	0.6	12	8		
TC A 0J 156□		4	8	15	±20,10	0.9				
TC A 0J 226□				22	1	1.4	14	10	12	
TC A 0J 336□				33		2.1	30	12	16	
TC A 0A 476 □				47		3.0	34	18	24	
TC A 1A 155 □				1.5		10	10	6	0	
TC A 1A 225 □				2.2			10	б	8	
TC A 1A 335 □				3.3		0.5	12		10	
TC A 1A 475 □	10	6.0	40	4.7	+20.40		12	8	10	20.0
TC A 1A 685 □	10	6.3	13	6.8	±20,10	0.7	12	0	10	20.0
TC A 1A 106 □				10		1.0	12		10	
TC A 1A 156 □				15		1.5	14	10	12	
TC A 1A 226 □				22		2.2	30	12	16	
TC A 1C 105 □				1.0						
TC A 1C 155 □				1.5		0.5				
TC A 1C 225 □				2.2		0.5	10	6		
TC A 1C 335 □	16	10	20	3.3	±20,10		10	6	8	20.0
TC A 1C 475 □				4.7		0.8				
TC A 1C 685 □				6.8	1	1.1]			
TC A 1C 106 □				10]	0.6	12	8	10	
TC A 1D 105 □	20	13	26	1.0	±20,10	0.5	10	6	8	20.0

 \square =Tolerance (M :±20%,K :±10%)

Packaging specifications



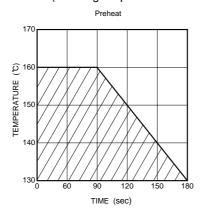


●Packaging style

Case code	package	Packaç	ging style	Symbol	Basic ordering units
М					4,000pcs
Р	Taping	plastic taping	φ180mmReel R	3,000pcs	
Α					2,000pcs

• Electrical characteristics and operation notes

(1) Soldering conditions (soldering temperature and soldering time)



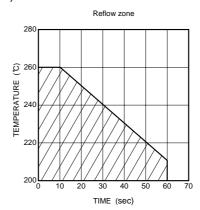


Fig.1 reflow soldering

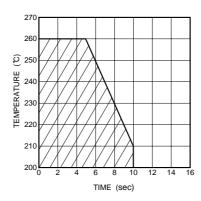


Fig.2 Flow soldering (Dip ·wave soldering)

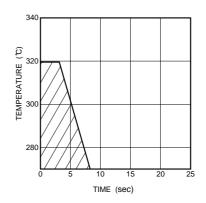


Fig.3 Hand soldering (Wattage: 30W MAX.)

(2) Leakage current-to-voltage ratio

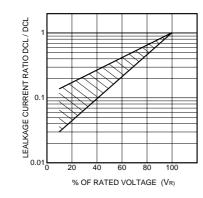
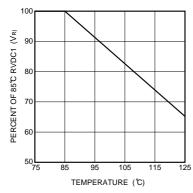


Fig.4

(3) Derating voltage as function of temperature



85	s°C	125℃				
Rated Voltage	Surge Voltage	Category Voltage	Surge Voltage			
(V.DC)	(V.DC)	(V.DC)	(V.DC)			
4	5.2	2.5	3.4			
6.3	8	4	5			
10	13	6.3	9			
16	20	10	12			
20	26	13	16			

Fig.5

(4) Reliability

The malfunction rate of tantalum solid state electrolytic capacitors varies considerably depending on the conditions of usage (ambient temperature, applied voltage, circuit resistance).

Formula for calculating malfunction rate

 $\lambda p = \lambda b \times (\pi E \times \pi SR \times \pi Q \times \pi CV)$

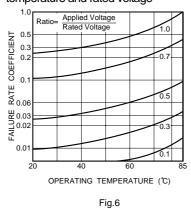
 λp : Malfunction rate stemming from operation

 $\begin{array}{lll} \lambda b & : \mbox{Basic malfunction rate} \\ \pi E & : \mbox{Environmental factors} \\ \pi S R & : \mbox{Series resistance} \\ \pi Q & : \mbox{Level of malfunction rate} \end{array}$

πcv: Capacitance

For details on how to calculate the malfunction rate stemming from operation, see the tantalum solid state electrolytic capacitors column in MIL-HDBK-217.

Malfunction rate as function of operating temperature and rated voltage



Malfunction rate as function of circuit resistance (ΩN)

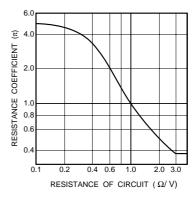


Fig.7

(5) Maximum power dissipation

Warming of the capacitor due to ripple voltage balances with warming caused by Joule heating and by radiated heat. Maximum allowable warming of the capacitor is to 5°C above ambient temperature. When warming exceeds 5°C, it can damage the dielectric and cause a short circuit.

Power dissipation (P) = $I^2 \bullet R$

Ripple current

P: As shown in table at right

R: Equivalent series resistance

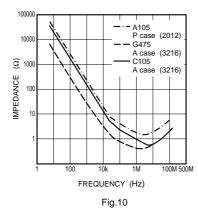
Notes:

- 1. Please be aware that when case size is changed, maximum allowable power dissipation is reduced.
- 2. Maximum power dissipation varies depending on the package. Be sure to use a case which will keep warming within the limits shown in the table below.

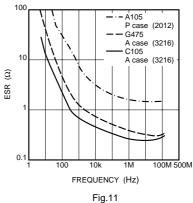
Allowable power dissipation (W) and maximum temperature rising

Temp.	+25℃	+55℃	+85℃	+125℃
P case (2012)	0.025	0.022	0.020	0.010
A case (3216)	0.070	0.063	0.056	0.028
Max. Temp Rise [°C]	5	5	5	2

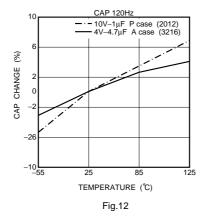
(6) Impedance frequency characteristics



(7) ESR frequency characteristics



(8) Temperature characteristics



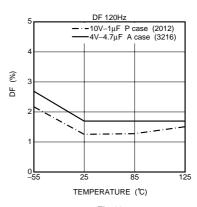
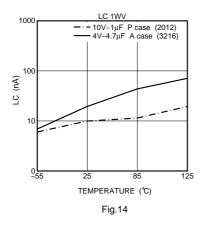
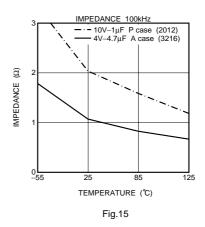


Fig.13





Rush current

The rush current is in inverse proportion to the ESR. The excessive rush current may cause a damage.

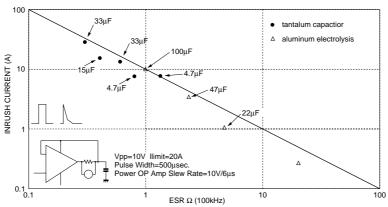


Fig. 16 Max. rush current and ESR

The rush current may be reduced by the protection resistors

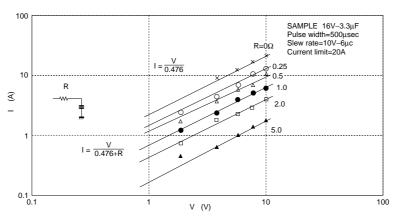


Fig. 17 Change in I max by protection resistors

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 use and operation. Please pay careful attention to the peripheral conditions when designing circuits
 and deciding upon circuit constants in the set.
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